

Application/Control No.	Applicant(s)/Patent under Reexamination
09/759,551	WILSON ET AL.
Examiner	Art Unit
Dinh Q. Nguyen	3752

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Class		Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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FAST SPARCH ATTACHED				
REP 6,318, 647				
6,311,903				
09/377,332				
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